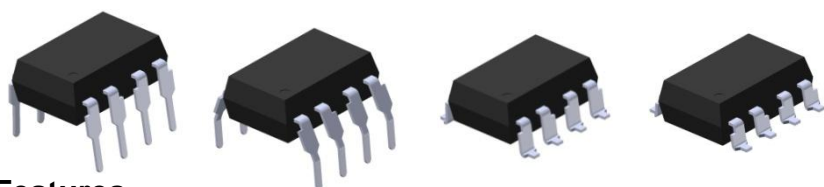


HIGH CMR HIGH SPEED 1Mbit/s TRANSISTOR PHOTOCOUPLER EL4504



Features

- Application for IPM and TTL
- High isolation voltage between input and output (Viso=5000 Vrms)
- High CMR at $V_{CM}=1500V$
- Open collector output
- Guaranteed performance from 0°C to 70°C
- Wide operating temperature range of -55°C to 100°C
- Pb free and RoHS compliant.
- UL and cUL approved(No. E214129)
- VDE approved (No. 132249)
- SEMKO approved
- NEMKO approved
- DEMKO approved
- FIMKO approved

Description

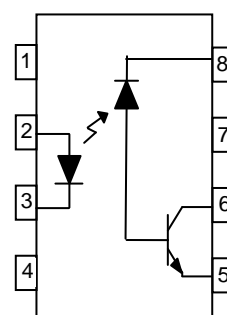
The EL4504 devices consist of an infrared emitting diode, optically coupled to a high speed photo detector transistor. A separate connection for the photodiode bias and output-transistor collector increase the speed by several orders of magnitude over conventional phototransistor couplers by reducing the base-collector capacitance of the input transistor.

The devices are packaged in an 8-pin DIP package and available in wide-lead spacing and SMD option.

Applications

- Inverter circuits and IPM interface
- Line receivers
- High speed logic ground isolation
- Analog signal ground isolation
- Replaces pulse transformers

Schematic



Pin Configuration

1. No Connection
2. Anode
3. Cathode
4. No Connection
5. Gnd
6. Vout
7. No Connection
8. VCC

Absolute Maximum Ratings (T_A=25°C)

| | Parameter | Symbol | Rating | Unit |
|--------|---|---------------------|------------|-------|
| Input | Forward current | I _F | 25 | mA |
| | Peak forward current (50% duty, 1ms P.W) | I _{FP} | 50 | mA |
| | Peak transient current (≤1μs P.W,300pps) | I _{Ftrans} | 1 | A |
| | Reverse voltage | V _R | 5 | V |
| | Power dissipation | P _{IN} | 45 | mW |
| Output | Power dissipation | P _O | 35 | mW |
| | Average Output current | I _{O(AVG)} | 8 | mA |
| | Peak Output current | I _{O(PK)} | 16 | mA |
| | Output voltage | V _O | -0.5 to 20 | V |
| | Supply voltage | V _{CC} | -0.5 to 30 | V |
| | Isolation voltage ^{*1} | V _{ISO} | 5000 | V rms |
| | Operating temperature | T _{OPR} | -55 ~ +100 | °C |
| | Storage temperature | T _{STG} | -55 ~ +125 | °C |
| | Soldering temperature ^{*2} | T _{SOL} | 260 | °C |

Notes:

*1 AC for 1 minute, R.H.= 40 ~ 60% R.H. In this test, pins 1, 2, 3 & 4 are shorted together, and pins 5, 6, 7 & 8 are shorted together.

*2 For 10 seconds.

Electrical Characteristics (T_A=0 to 70°C unless specified otherwise)

Input

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Condition |
|--|----------------------------------|------|------|------|-------|-----------------------|
| Forward voltage | V _F | - | 1.4 | 1.8 | V | I _F = 16mA |
| Reverse voltage | V _R | 5.0 | - | - | V | I _R = 10μA |
| Temperature coefficient of forward voltage | ΔV _F /ΔT _A | - | -1.9 | - | mV/°C | I _F = 16mA |

Output

| Parameter | Symbol | Min. | Typ.* | Max. | Unit | Conditions |
|---------------------------|------------------|------|-------|------|------|---|
| Logic High Output Current | I _{OH} | - | 0.001 | 0.5 | μA | I _F =0mA, V _O =V _{CC} =5.5V, T _A =25°C |
| | | | 0.01 | 1 | | I _F =0mA, V _O =V _{CC} =15V, T _A =25°C |
| | | - | - | 50 | | I _F =0mA, V _O =V _{CC} =15V |
| Logic Low Supply Current | I _{CCL} | - | 140 | 200 | μA | I _{F1} =I _{F2} 16mA, V _O =Open, V _{CC} =15V |
| Logic High Supply Current | I _{CCH} | - | 0.01 | 1 | μA | I _F =0mA, V _O =Open, V _{CC} =15V, T _A =25°C |
| | | - | - | 2 | | I _F =0mA, V _O =Open, V _{CC} =15V |

* Typical values at T_A = 25°C

Transfer Characteristics (T_A=0 to 70°C unless specified otherwise)

| Parameter | Symbol | Min. | Typ.* | Max. | Unit | Conditions |
|--------------------------|-----------------|------|-------|------|------|--|
| Current Transfer Ratio | CTR | 25 | - | 60 | % | I _F = 16mA, V _O = 0.4V, V _{CC} =4.5V, T _A =25°C |
| | | 21 | 35 | | | I _F = 16mA, V _O = 0.5V, V _{CC} =4.5V |
| | | 26 | - | 65 | | I _F = 12mA, V _O = 0.4V, V _{CC} =4.5V, T _A =25°C |
| | | 22 | 39 | - | | I _F = 12mA, V _O = 0.5V, V _{CC} =4.5V |
| Logic Low Output Voltage | V _{OL} | - | 0.25 | 0.4 | V | I _F = 16mA, I _O = 4.0mA, V _{CC} =4.5V, T _A =25°C |
| | | - | | 0.5 | | I _F = 16mA, I _O = 3.3mA, V _{CC} =4.5V |

* Typical values at T_A = 25°C

Switching Characteristics ($T_A=0$ to 70°C unless specified otherwise)

| Parameter | Symbol | Min. | Typ.* | Max. | Unit | Conditions |
|---|-------------------|-------|--------|------|------------------------|--|
| Propagation Delay Time to Logic Low (Fig.8) | t_{PHL} | - | 0.25 | 0.4 | μs | Pulse $f=20\text{KHz}$, Duty cycle = 10%, $I_F = 16\text{mA}$, $V_{CC}=5\text{V}$, $R_L=1.9\text{K}\Omega$, $V_{THHL}=1.5\text{V}$, $T_A=25^\circ\text{C}$ |
| | | - | 0.6 | 0.8 | | Pulse $f=10\text{kHz}$, Duty cycle = 50%, $I_F = 12\text{mA}$, $V_{CC}=15\text{V}$, $R_L=20\text{k}\Omega$, $V_{THHL}=1.5\text{V}$, $T_A=25^\circ\text{C}$ |
| | | - | - | 0.4 | | Pulse $f=20\text{kHz}$, Duty cycle = 10%, $I_F = 16\text{mA}$, $V_{CC}=5\text{V}$, $R_L=1.9\text{k}\Omega$, $V_{THHL}=1.5\text{V}$ |
| | | - | - | 1.0 | | Pulse $f=10\text{kHz}$, Duty cycle = 50%, $I_F = 12\text{mA}$, $V_{CC}=15\text{V}$, $R_L=20\text{k}\Omega$, $V_{THHL}=1.5\text{V}$ |
| Propagation Delay Time to Logic High (Fig.8) | t_{PLH} | - | 0.25 | 0.4 | μs | Pulse $f=20\text{kHz}$, Duty cycle = 10%, $I_F = 16\text{mA}$, $V_{CC}=5\text{V}$, $R_L=1.9\text{k}\Omega$, $V_{THLH}=1.5\text{V}$, $T_A=25^\circ\text{C}$ |
| | | - | 1.0 | 1.2 | | Pulse $f=10\text{kHz}$, Duty cycle = 50%, $I_F = 12\text{mA}$, $V_{CC}=15\text{V}$, $R_L=20\text{k}\Omega$, $V_{THLH}=1.5\text{V}$, $T_A=25^\circ\text{C}$ |
| | | - | - | 0.7 | | Pulse $f=20\text{kHz}$, Duty cycle = 10%, $I_F = 16\text{mA}$, $V_{CC}=5\text{V}$, $R_L=1.9\text{k}\Omega$, $V_{THLH}=2\text{V}$ |
| | | - | - | 1.4 | | Pulse $f=10\text{kHz}$, Duty cycle = 50%, $I_F = 12\text{mA}$, $V_{CC}=15\text{V}$, $R_L=20\text{k}\Omega$, $V_{THLH}=2\text{V}$ |
| Propagation Delay Difference Between Any 2 Parts | $t_{PLH}-t_{PHL}$ | -0.4 | 0.4 | 0.9 | $\text{V}/\mu\text{s}$ | Pulse $f=10\text{kHz}$, Duty cycle = 50%, $I_F = 12\text{mA}$, $V_{CC}=15\text{V}$, $R_L=20\text{k}\Omega$, $V_{THHL}=1.5\text{V}$, $V_{THLH}=2\text{V}$, $T_A=25^\circ\text{C}$ |
| | | -0.7 | - | 1.3 | | Pulse $f=10\text{kHz}$, Duty cycle = 50%, $I_F = 12\text{mA}$, $V_{CC}=15\text{V}$, $R_L=20\text{k}\Omega$, $V_{THLH}=1.5\text{V}$, $V_{THLH}=2\text{V}$ |
| Common Mode Transient Immunity at Logic Low (Fig.9)*3 | CM_L | 1,000 | 10,000 | - | $\text{V}/\mu\text{s}$ | $I_F = 16\text{mA}$, $V_{CM}=10\text{Vp-p}$, $R_L=4.1\text{K}\Omega$, $T_A=25^\circ\text{C}$ |
| | | 1,000 | 10,000 | - | | $I_F = 16\text{mA}$, $V_{CM}=1000\text{Vp-p}$, $R_L=1.9\text{K}\Omega$, $T_A=25^\circ\text{C}$ |

| | | | | | | |
|---|-----------------|--------|---|---|------|---|
| Common Mode Transient Immunity at Logic Low (Fig.9)* ₃ | CM _H | 15,000 | - | - | V/μs | I _F = 0mA , V _{CC} =5V, V _{CM} =1500Vp-p, R _L =1.9KΩ, T _A =25°C |
| | | 15,000 | - | - | | I _F = 0mA , V _{CC} =15V, V _{CM} =1500Vp-p, R _L =20KΩ, T _A =25°C |
| Common Mode Transient Immunity at Logic Low (Fig.9)* ₃ | CM _L | 15,000 | - | - | V/μs | I _F = 16mA , V _{CC} =5V, V _{CM} =1500Vp-p, R _L =1.9KΩ, T _A =25°C |
| | | 15,000 | - | - | | I _F = 12mA , V _{CC} =15V, V _{CM} =1500Vp-p, R _L =20KΩ, T _A =25°C |
| | | 15,000 | - | - | | I _F = 16mA , V _{CC} =15V, V _{CM} =1500Vp-p, R _L =20KΩ, T _A =25°C |

* Typical values at T_A = 25°C

Typical Electro-Optical Characteristics Curves

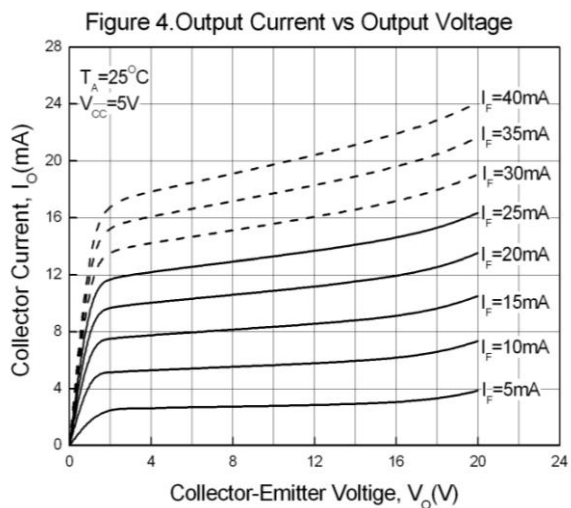
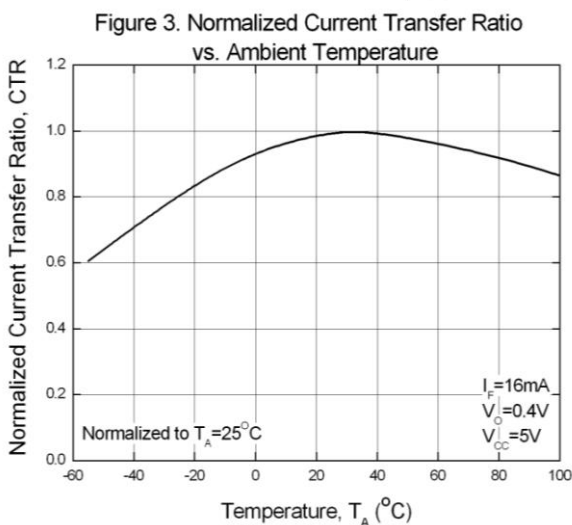
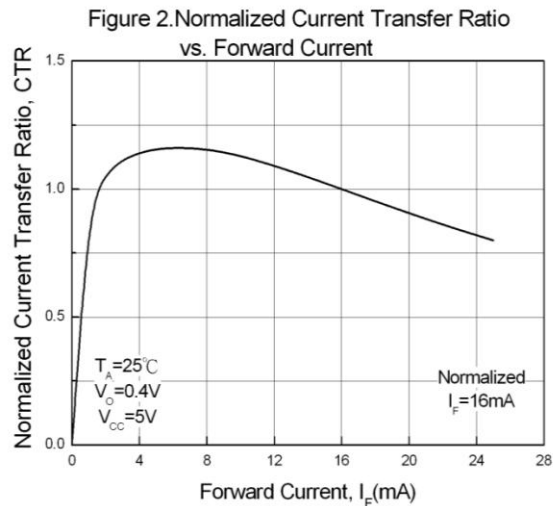
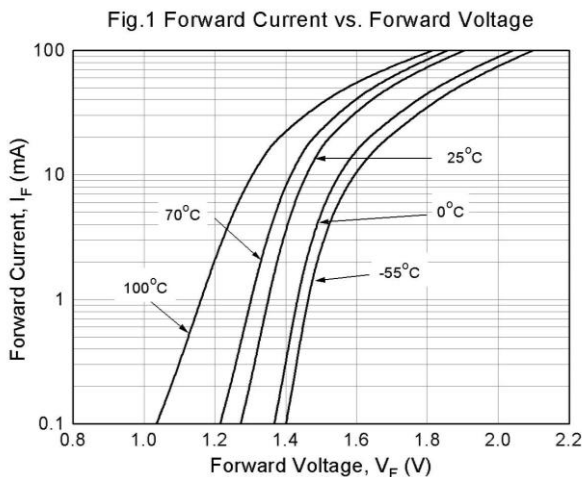


Figure 5. Logic High Output Current vs Ambient Temperature

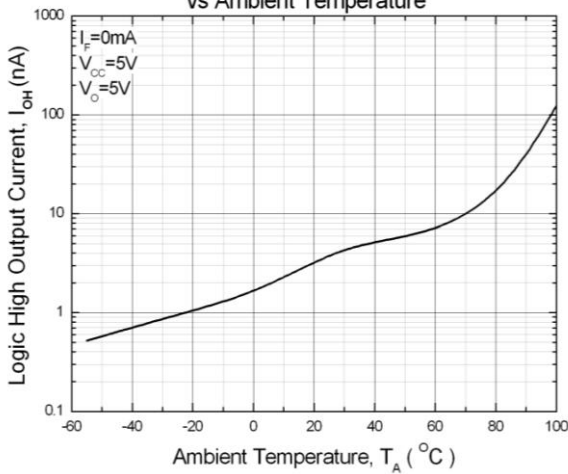


Figure 6. Propagation Delay vs. Temperature

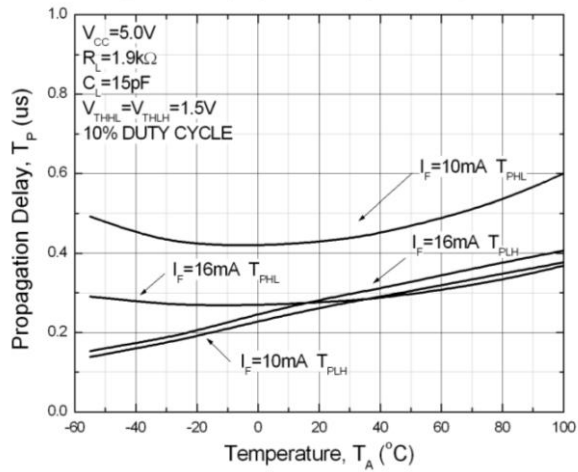


Figure 7. Propagation Delay vs. Load Resistance

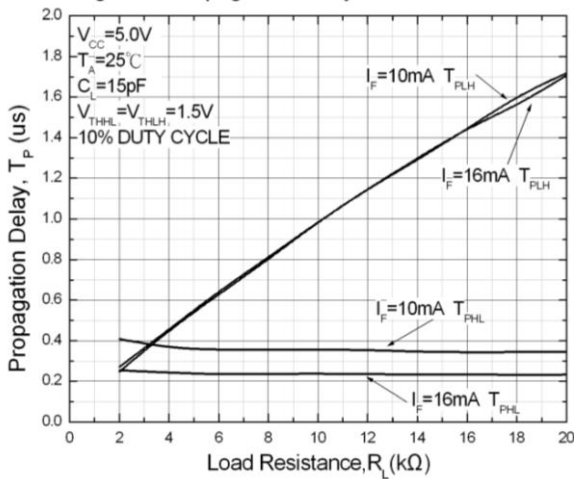


Figure 8. Propagation Delay vs. Load Resistance

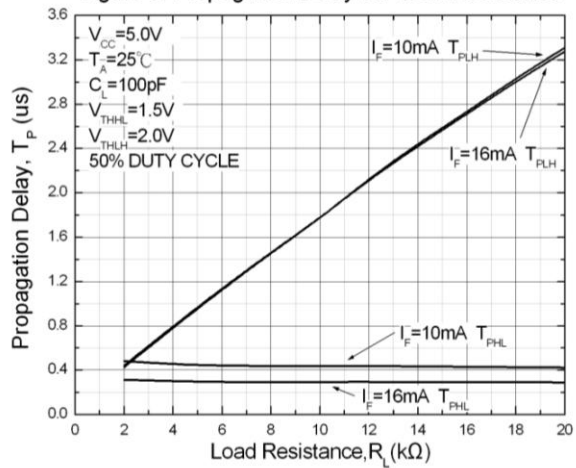


Figure 9. Propagation Delay vs. Temperature

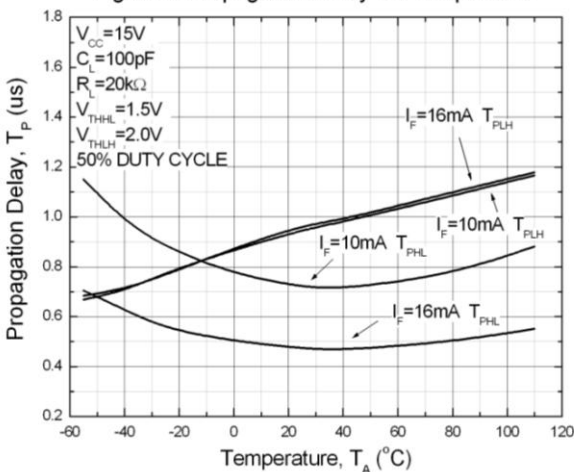


Figure 10. Propagation Delay vs. Load Resistance

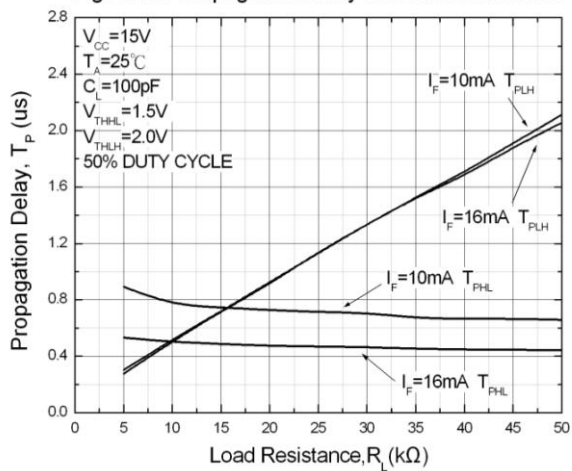


Figure 11. Propagation Delay vs. Load Capacitance

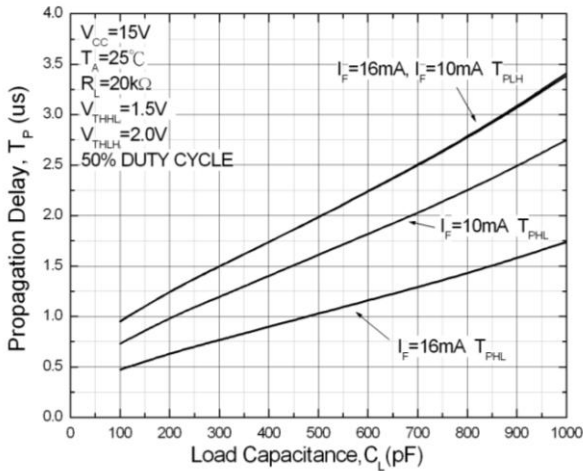


Figure 12 Switching Time Test Circuit & Waveform

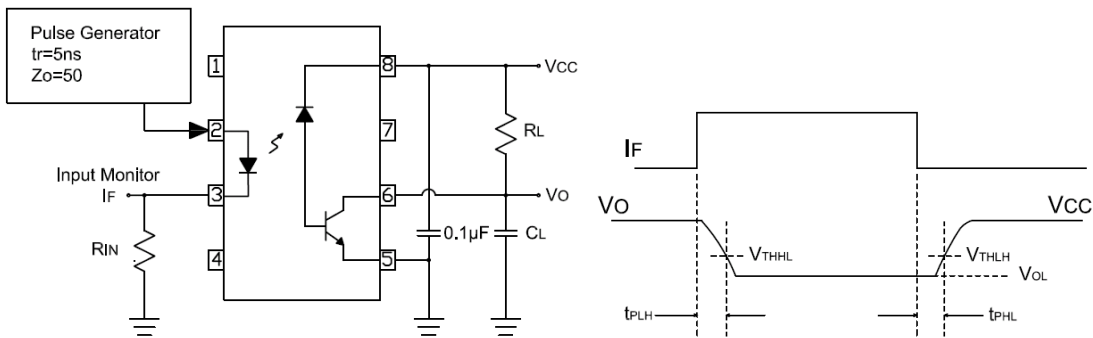
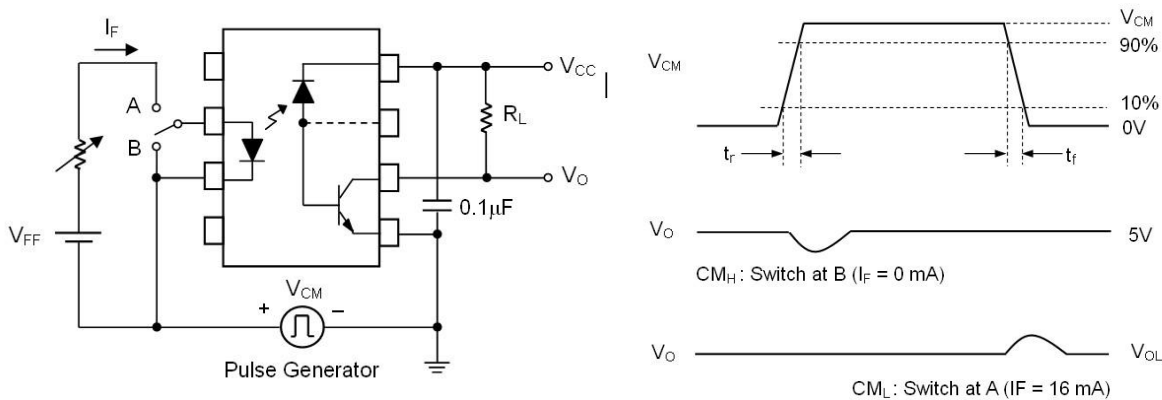


Figure 13 Transient Immunity Test Circuit & Waveform



*3 Common mode transient immunity in logic high level is the maximum tolerable (positive) dV_{CM}/dt on the leading edge of the common mode pulse signal V_{CM} , to assure that the output will remain in a logic high state (i.e., $V_O > 2.0\text{V}$).

Common mode transient immunity in logic low level is the maximum tolerable (negative) dV_{CM}/dt on the trailing edge of the common mode pulse signal, V_{CM} , to assure that the output will remain in a logic low state (i.e., $V_O < 0.8\text{V}$).

Order Information

Part Number

EL4504Y(Z)-V

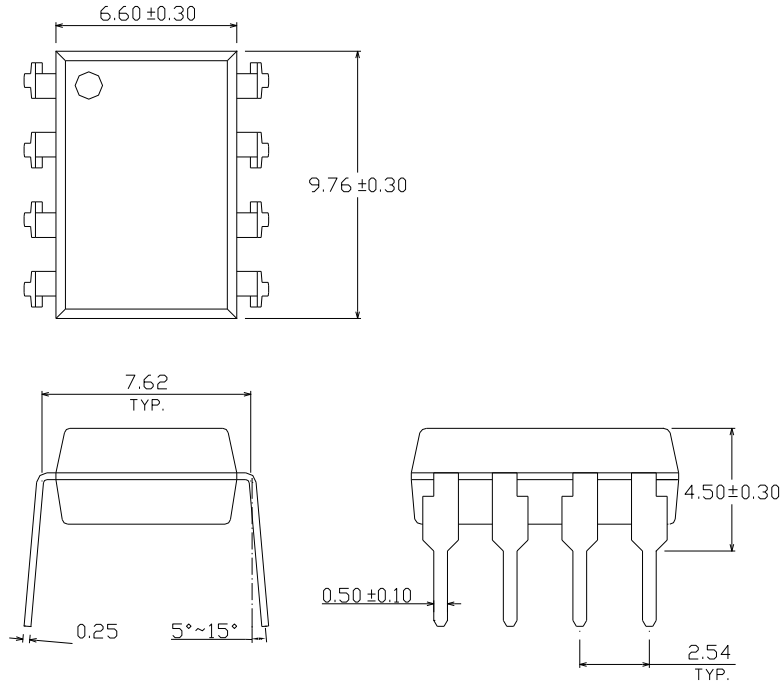
Note

- X = Part no. (0 or 1)
- Y = Lead form option (S, S1, M or none)
- Z = Tape and reel option (TA, TB or none)
- V = VDE (optional)

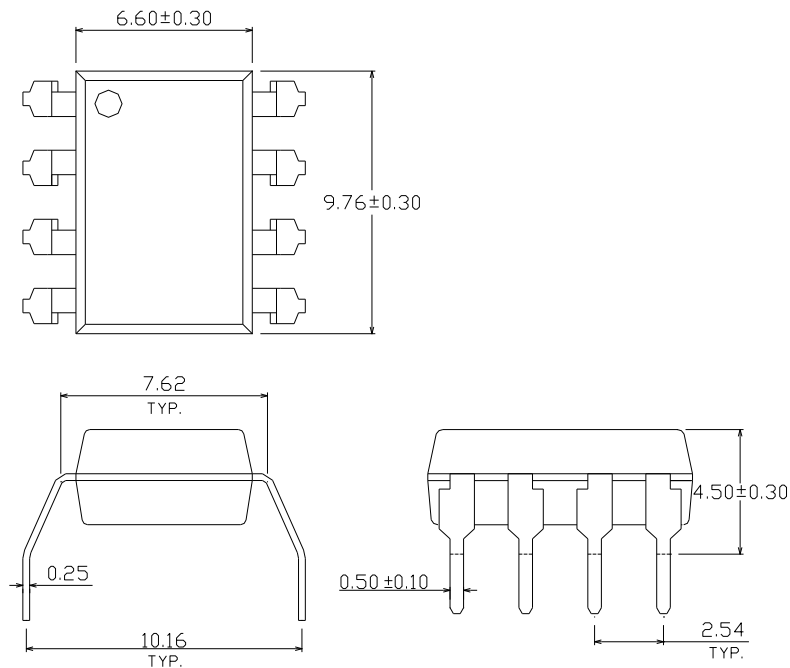
| Option | Description | Packing quantity |
|---------|---|---------------------|
| None | Standard DIP-8 for EL4504 | 45 units per tube |
| M | Wide lead bend (0.4 inch spacing) | 45 units per tube |
| S (TA) | Surface mount lead form + TA tape & reel option | 1000 units per reel |
| S1 (TA) | Surface mount lead form (low profile) + TA tape & reel option | 1000 units per reel |

Package Dimension
(Dimensions in mm)

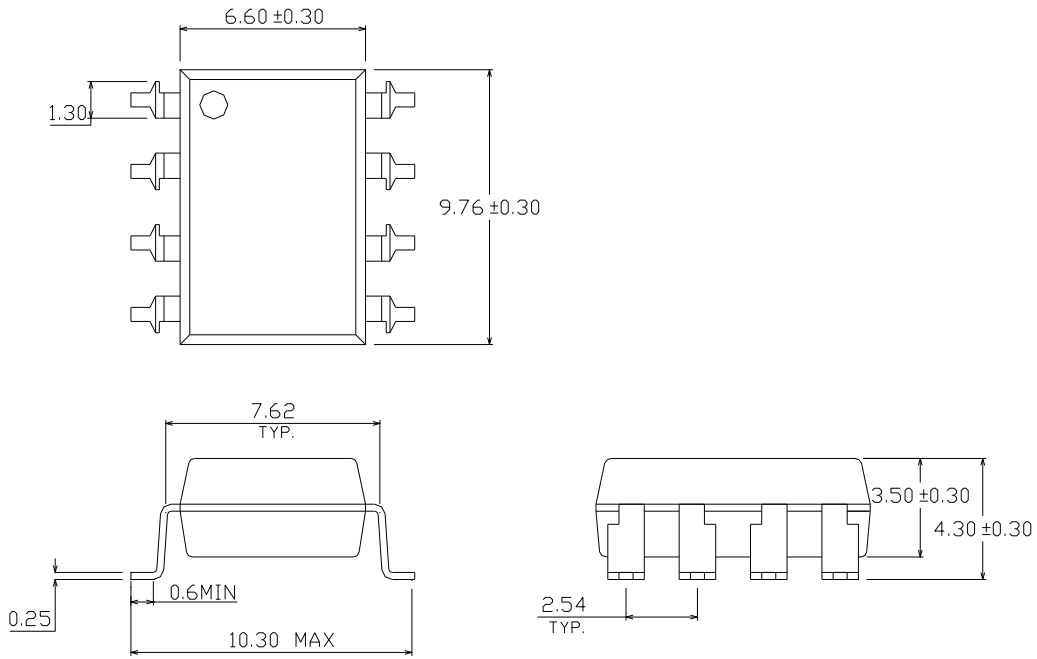
Standard DIP Type



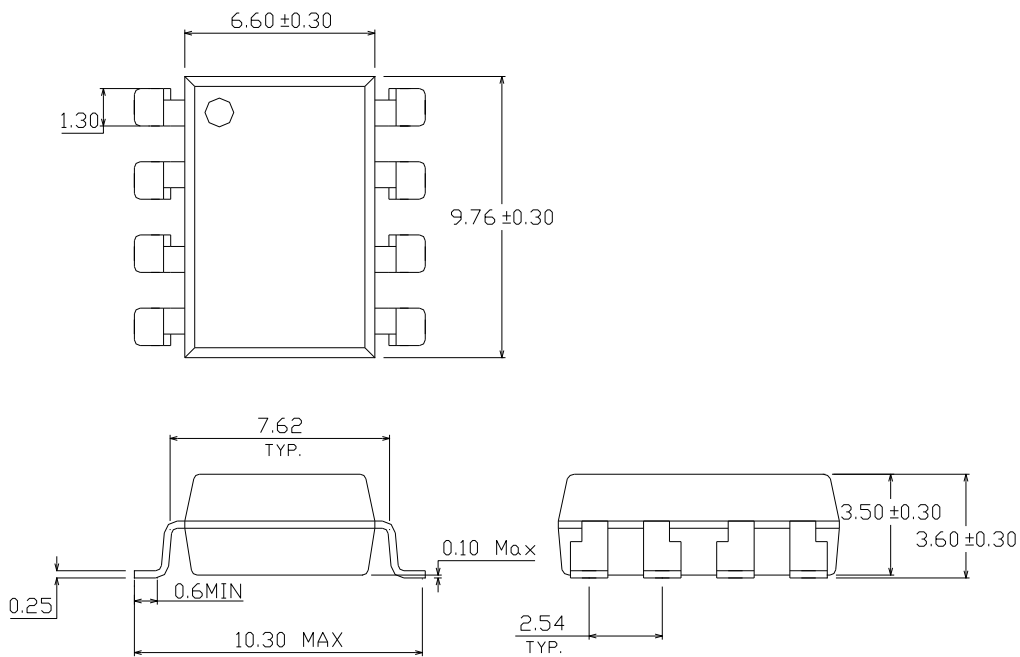
Option M Type



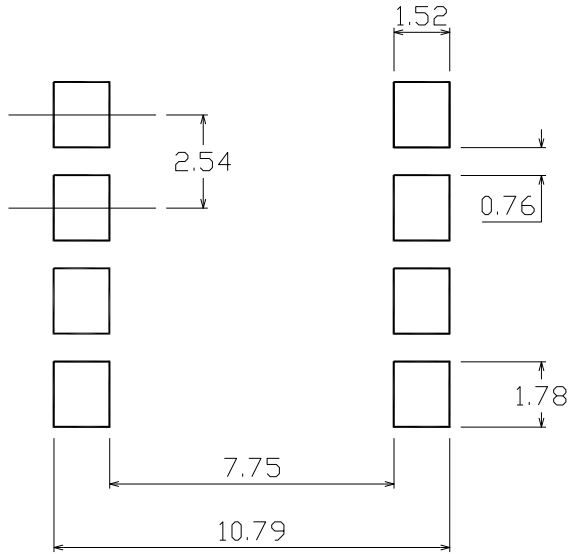
Option S Type



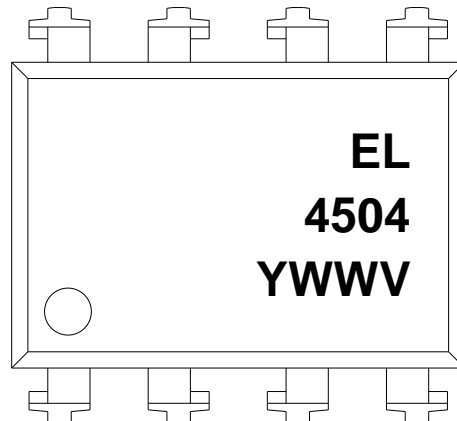
Option S1 Type



Recommended pad layout for surface mount leadform



Device Marking

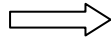
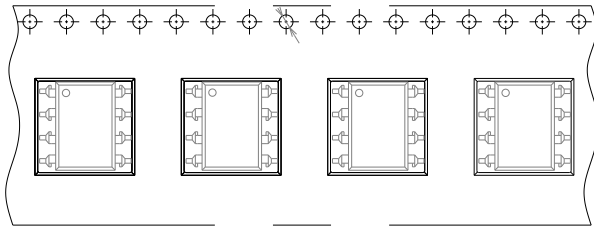


Notes

- | | |
|------|---------------------------|
| EL | denotes EVERLIGHT |
| 4504 | denotes Device Number |
| Y | denotes 1 digit Year code |
| WW | denotes 2 digit Week code |
| V | denotes VDE (optional) |

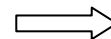
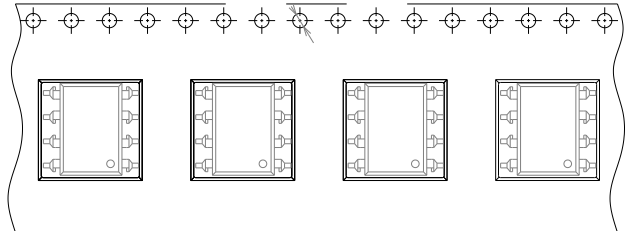
Tape & Reel Packing Specifications

Option TA



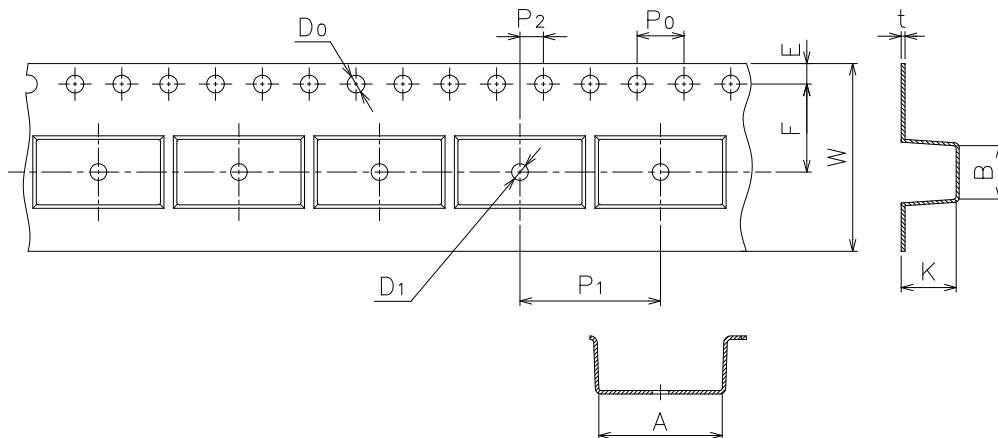
Direction of feed from reel

Option TB



Direction of feed from reel

Tape dimension

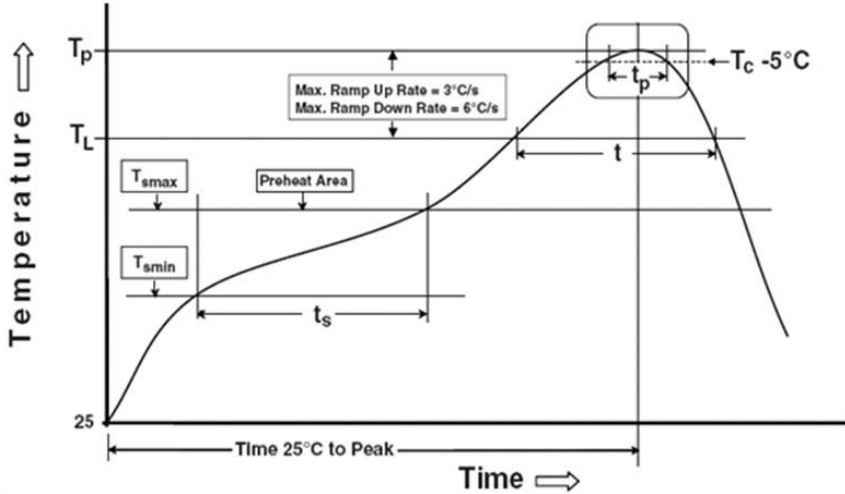


| | | | | | | |
|---------------|-----------|-----------|-----------|-----------|---------------|----------|
| Dimension No. | A | B | Do | D1 | E | F |
| Dimension(mm) | 10.4±0.1 | 10.0±0.1 | 1.5±0.1 | 1.5±0.1 | 1.75±0.1 | 7.5±0.1 |
| Dimension No. | Po | P1 | P2 | t | W | K |
| Dimension(mm) | 4.0±0.1 | 12.0±0.1 | 2.0±0.1 | 0.4±0.1 | 16.0+0.3/-0.1 | 4.5±0.1 |

Precautions for Use

1. Soldering Condition

1.1 (A) Maximum Body Case Temperature Profile for evaluation of Reflow Profile



Note:

Reference: IPC/JEDEC J-STD-020D

Preheat

| | |
|--|-----------------|
| Temperature min (T_{smin}) | 150 °C |
| Temperature max (T_{smax}) | 200°C |
| Time (T_{smin} to T_{smax}) (t_s) | 60-120 seconds |
| Average ramp-up rate (T_{smax} to T_p) | 3 °C/second max |

Other

| | |
|--|------------------|
| Liquidus Temperature (T_L) | 217 °C |
| Time above Liquidus Temperature (t_L) | 60-100 sec |
| Peak Temperature (T_p) | 260°C |
| Time within 5 °C of Actual Peak Temperature: $T_p - 5^\circ\text{C}$ | 30 s |
| Ramp- Down Rate from Peak Temperature | 6°C /second max. |
| Time 25°C to peak temperature | 8 minutes max. |
| Reflow times | 3 times |

DISCLAIMER

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2. When using this product, please observe the absolute maximum ratings and the instructions for using outlined in these specification sheets. EVERLIGHT assumes no responsibility for any damage resulting from use of the product which does not comply with the absolute maximum ratings and the instructions included in these specification sheets.
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